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IN THE UNITED STATES PATENT AND TRADEMARK OFFICE

APPLICATION SER	RIAL NO	
INVENTORSHIP		Salman Akram et al.
ASSIGNEE		Micron Technology, Inc.
GROUP ART UNIT	***	
EXAMINER		Unknown
ATTORNEY'S DOC	KET NO	MI22-2469
TITLE:	Methods of Sensing Temperature of ar	Electronic Device Workpiece

Commissioner for Patents P.O. Box 1450 Alexandria VA 22313-1450

CERTIFICATE OF FACSIMILE TRANSMISSION UNDER 37 CFR 1.8

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- 1. Transmittal Form (PTO/SB/21)
- 2. Supplemental Information Disclosure Statement with Form PTO-1449
- 3. Cited Reference (1)

Dated: 9/20/2004

By:

Natalie King

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	Application Number	10/773,383						
TRANSMITTAL	Filing Date	Feb. 6, 2004						
FORM	First Named Inventor	Salman Akram et al.						
(to be used for all correspondence after initial fluing)	Art Unit	2811						
	Examiner Name	Unknown						
Total Number of Pages in This Submission	Attorney Docket Number	MI22-2469						
ENCLOSURES (Check all that apply)								
Fee Transmittal Form Drawing(s)								
r :	F APPLICANT, ATTORNE	Y, OR AGENT						
James D. Shaurette, Reg. No. 39,833 or Wells St. John, P.S.	3	· •						
Signature								
Date 9 2004								
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INVENTORSHIP	Salman Akram et al.
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EXAMINER	Unknown
ATTORNEY'S DOCKET NO	
TITLE: Methods of Sensing Temperature of	of an Electronic Device Workpiece

SUPPLEMENTAL INFORMATION DISCLOSURE STATEMENT

References -- See Attached Form PTO-1449

The Examiner's attention is directed to the references which are listed on the attached Form PTO-1449, copies of which are attached. No admission is made regarding whether all the submitted references are prior art.

Citation of the referenced art is respectfully requested.

Respectfully submitted,

ed: 9/20/04

By:

James D. Shauret Reg. No. 39,833

Form PTO-1449 LIST OF ART CITED BY (Use several aheats if r		U.S. DEPARTMENT OF COMMERCE PATENT AND TRADEMARX OFFICE					ATTY, DOCKET NO. MI22-2460				SERIAL NO. 10773,389			
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				FILING DATE Petruary 8, 2004				GROUP 2811						
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